

ABSTRACT OF THE DISCLOSURE.

A first inspection functionality is provided to obtain information about a first attribute at a conductor location on an electrical circuit. A second inspection
5 functionality is provided to obtain information about a second attribute at the conductor location. A combination of first attribute information and second attribute information is analyzed to determine an inspection attribute of the conductor at the conductor location.
10 Attribute information may relate to one or more of: reflectance, fluorescence or height.